


<b>Search Notes</b>  	<b>Application/Control No.</b>  10753274	<b>Applicant(s)/Patent Under Reexamination</b>  SHANKAR ET AL.
	<b>Examiner</b>  Jamal J King	<b>Art Unit</b>  4141

### SEARCHED

Class	Subclass	Date	Examiner
704	270	11/26/2007	Vincent Harper
370	241	11/26/2007	Clemence Han
370	516	11/26/2007	David Vincent

### SEARCH NOTES

Search Notes	Date	Examiner
EAST was used to search USPGPub, US PAT, EPO and DERWENT	11/26/2007	Jamal J King
NPL was used to search documents in IEEE	11/28/2007	Jamal J King

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner